IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology
- 180µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

• SGW25N120



Applications:

drives, SMPS, resonant applications

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T120CS	1200V	25A	6.59 x 6.49 mm ²	sawn on foil	Q67050- A4048-A001

MECHANICAL PARAMETER:

Raster size	6.59 x 6.49				
Emitter pad size	2 x (2.18 x 1.58)	1			
Gate pad size	1.06 x 0.65	1			
Area total / active	42.8 / 33.5				
Thickness	180	μm			
Wafer size	150	mm			
Flat position	180	grd			
Max.possible chips per wafer	334 pcs				
Passivation frontside	Photoimide				
Emitter metallization 3200 nm Al Si 1%					
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bor	nding			
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	75	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i arameter	Symbol	Conditions	min.	typ.	max.	J.iii
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} = 1.5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =25A	2.5	3.0	3.6	٧
Gate-emitter threshold voltage	V _{GE(th)}	I _C =1mA , V _{GE} =V _{CE}	3.0	4.0	5.0	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			3	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			120	nA

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions		Value		
raiametei	Symbol	Conditions	min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V,	-	2150	2600	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	160	190	
Reverse transfer capacitance	Crss	f=1MHz	-	110	130	

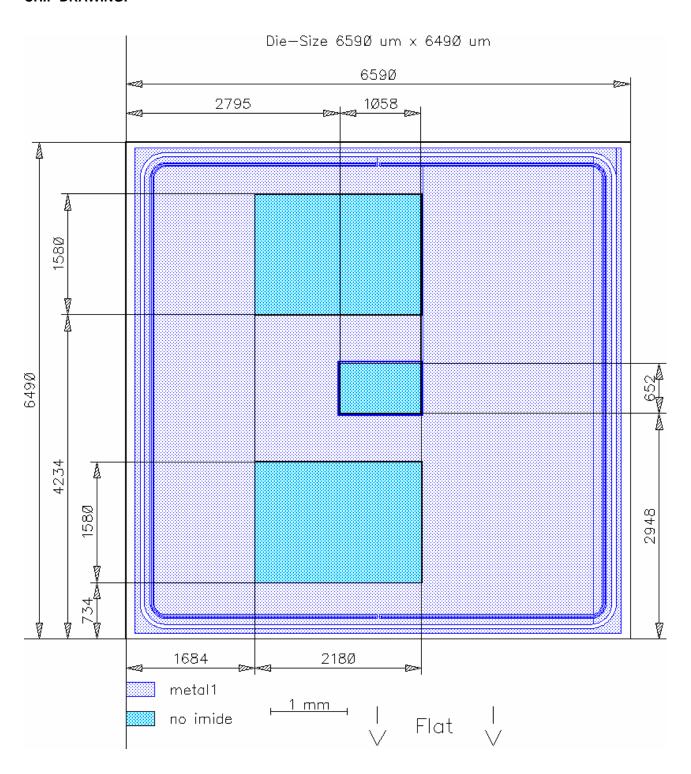
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol Conditions 1)	Value			Unit	
- arameter	Symbol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j = 150 ° C	-	50	60	ns
Rise time	t_{r}	$V_{\rm CC} = 800 \rm V$,	-	36	43	
Turn-off delay time	$t_{d(off)}$	I _C =25A, V _{GE} =-15/15V,	-	820	990	
Fall time	t_{f}	$R_{\rm G}$ = 22 Ω	-	42	50	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	SGW25N120				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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